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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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International Rectifier

IRL3803PbF

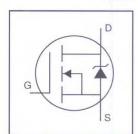
- Lead-Free
- · Logic-Level Gate Drive
- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

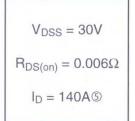
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

HEXFET® Power MOSFET







Absolute Maximum Ratings

	Parameter	Max.	Units	
I _D @ T _C = 25°C Continuous Drain Current, V _{GS} @ 10V I _D @ T _C = 100°C Continuous Drain Current, V _{GS} @ 10V		140⑤		
		98⑤	A	
I _{DM}	Pulsed Drain Current ①	470		
P _D @T _C = 25°C	Power Dissipation	200	W	
	Linear Derating Factor	1.3	W/°C	
V _{GS} Gate-to-Source Voltage		±16	V	
E _{AS}	Single Pulse Avalanche Energy ②	610	mJ	
Avalanche Current®		71	A	
E _{AR}	Repetitive Avalanche Energy①	20	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns	
TJ	Operating Junction and	-55 to + 175		
T _{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)		

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units	
ReJC	Junction-to-Case			0.75		
R _{ecs}	Case-to-Sink, Flat, Greased Surface		0.50		°C/W	
$R_{\theta JA}$	Junction-to-Ambient			62		

Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	30	_	_	٧	V _{GS} = 0V, I _D = 250μA	
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.052	_	V/°C	Reference to 25°C, I _D = 1mA	
R _{DS(on)}	Static Drain-to-Source On-Resistance	_	_	0.006	Ω	V _{GS} = 10V, I _D = 71A ④	
		_		0.009	77	V _{GS} = 4.5V, I _D = 59A ④	
V _{GS(th)}	Gate Threshold Voltage	1.0		_	V	V _{DS} = V _{GS} , I _D = 250μA	
9fs	Forward Transconductance	55		_	S	V _{DS} = 25V, I _D = 71A	
I _{DSS}	Drain-to-Source Leakage Current	_	_	25	μА	V _{DS} = 30V, V _{GS} = 0V	
-033		_	_	250		V _{DS} = 24V, V _{GS} = 0V, T _J = 150°C	
I _{GSS}	Gate-to-Source Forward Leakage	_		100		V _{GS} = 16V	
1655	Gate-to-Source Reverse Leakage	_	_	-100	nA	V _{GS} = -16V	
Q_g	Total Gate Charge		_	140		I _D = 71A	
Q _{gs}	Gate-to-Source Charge	_	_	41	nC	V _{DS} = 24V	
Q _{gd}	Gate-to-Drain ("Miller") Charge	-	_	78		V _{GS} = 4.5V, See Fig. 6 and 13 ⁽⁴⁾	
t _{d(on)}	Turn-On Delay Time	_	14	_		V _{DD} = 15V	
tr	Rise Time	_	230			I _D = 71A	
t _{d(off)}	Turn-Off Delay Time		29		ns	$R_G = 1.3\Omega, V_{GS} = 4.5V$	
tf	Fall Time		35			R _D = 0.20Ω, See Fig. 10 ④	
L _D	Internal Drain Inductance	,—	4.5	-		Between lead, 6mm (0.25in.)	
-s	Internal Source Inductance	==	7.5	_	nH	from package and center of die contact	
Ciss	Input Capacitance		5000	_		V _{GS} = 0V	
Coss	Output Capacitance	_	1800	_	pF	V _{DS} = 25V	
Orss	Reverse Transfer Capacitance		880			f = 1.0MHz, See Fig. 5	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)	-	_	140⑤	A	MOSFET symbol showing the	
Ism	Pulsed Source Current (Body Diode) ①		_	470	^	integral reverse p-n junction diode.	
V _{SD}	Diode Forward Voltage	_		1.3	V	$T_J = 25^{\circ}\text{C}, I_S = 71\text{A}, V_{GS} = 0\text{V}$ @ $T_J = 25^{\circ}\text{C}, I_F = 71\text{A}$ $di/dt = 100\text{A}/\mu\text{s}$ @	
t _{rr}	Reverse Recovery Time		120	180	ns		
Qrr	Reverse RecoveryCharge	_	450	680	nC		
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

- Notes:

 ① Repetitive rating; pulse width limited by
- max. junction temperature. (See fig. 11) $V_{DD} = 15V$, starting $T_J = 25^{\circ}C$, $L = 180\mu H$ $R_G = 25\Omega$, $I_{AS} = 71A$. (See Figure 12) $I_{SD} \le 71A$, di/dt $\le 130A/\mu s$, $I_{DD} \le V_{(BR)DSS}$, $I_{CD} \le 1750$
- $T_J \le 175^{\circ}C$
- ④ Pulse width ≤ 300µs; duty cycle ≤ 2%.
- © Caculated continuous current based on maximum allowable junction temperature; for recommended current-handling of the package refer to Design Tip # 93-4

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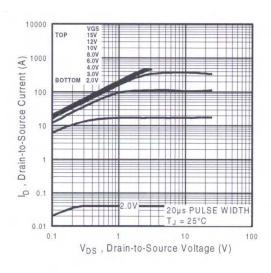


Fig 1. Typical Output Characteristics, $T_J = 25^{\circ}C$

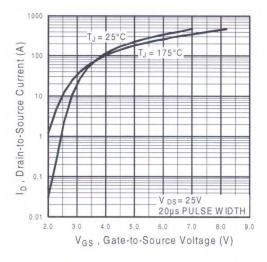


Fig 3. Typical Transfer Characteristics

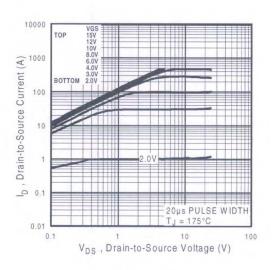


Fig 2. Typical Output Characteristics, $T_J = 175^{\circ}C$

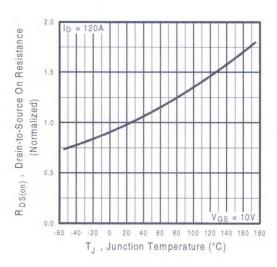


Fig 4. Normalized On-Resistance Vs. Temperature

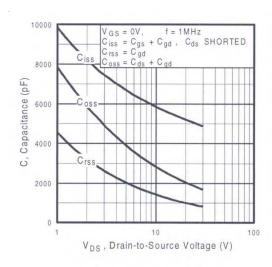


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

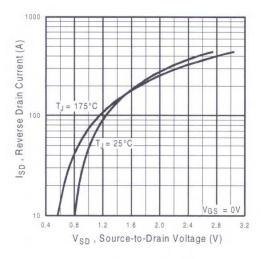


Fig 7. Typical Source-Drain Diode Forward Voltage

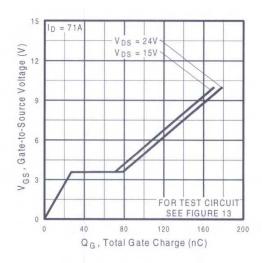


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

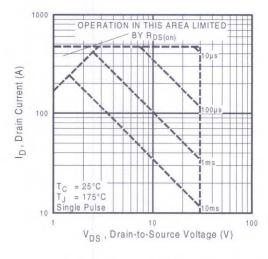


Fig 8. Maximum Safe Operating Area

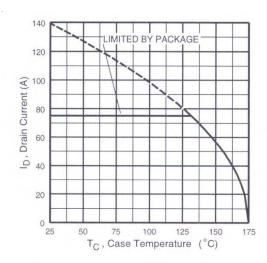


Fig 9. Maximum Drain Current Vs. Case Temperature

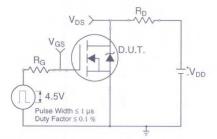


Fig 10a. Switching Time Test Circuit

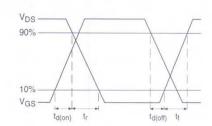


Fig 10b. Switching Time Waveforms

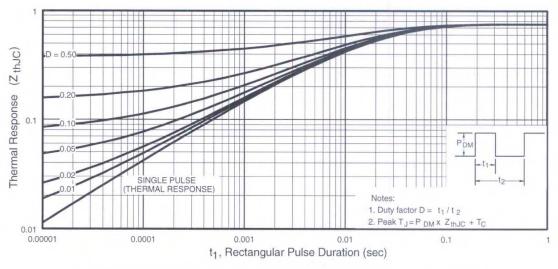


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

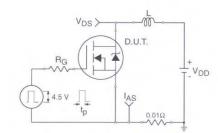


Fig 12a. Unclamped Inductive Test Circuit

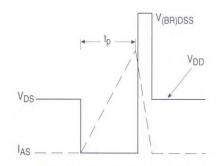


Fig 12b. Unclamped Inductive Waveforms

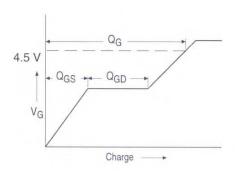


Fig 13a. Basic Gate Charge Waveform

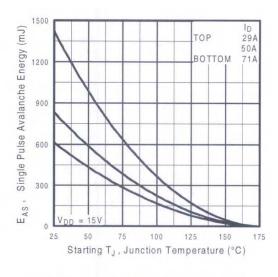


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

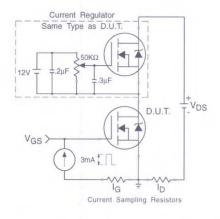
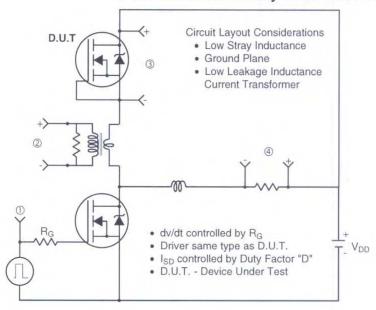


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



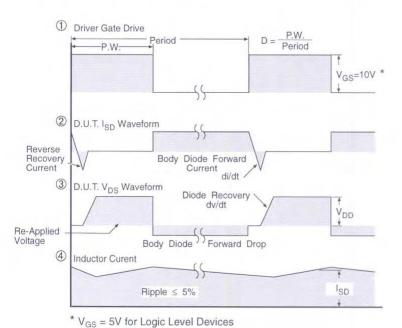
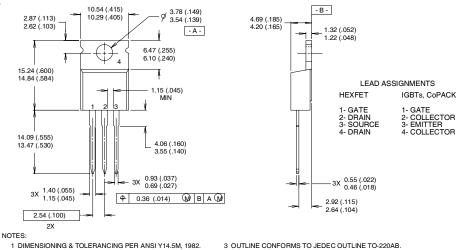


Fig 14. For N-Channel HEXFETS

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- 2 CONTROLLING DIMENSION : INCH
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

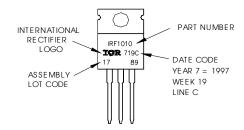
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010 LOT CODE 1789

ASSEMBLED ON WW 19, 1997

IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/